

# DIM800DCM12-A000

# **IGBT Chopper Module**

DS5548-1.2 May 2002

#### **FEATURES**

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Non Punch Through Silicon
- Isolated MMC Base with AIN Substrates

### **APPLICATIONS**

- Inverters
- Motor Controllers
- Traction Drives

The Powerline range of modules includes half bridge, dual, chopper, bi-directional and single switch configurations covering voltages from 600V to 3300V and currents up to 2400A.

The DIM800DCM12-A000 is a 1200V, n channel enhancement mode insulated gate bipolar transistor (IGBT) chopper module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus full 10µs short circuit withstand. This module is optimised for applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

### **ORDERING INFORMATION**

Order As:

### DIM800DCM12-A000

Note: When ordering, please use the whole part number.

#### **KEY PARAMETERS**

V <sub>CES</sub>		1200V
V <sub>CE(sat)</sub> *	(typ)	2.2V
I <sub>C</sub>	(max)	800A
I <sub>C(PK)</sub>	(max)	1600A

\*(measured at the power busbars and not the auxiliary terminals)

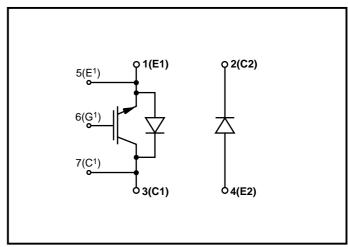


Fig. 1 Chopper circuit diagram

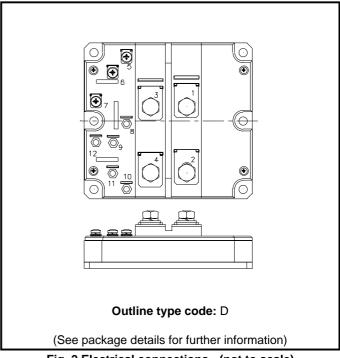


Fig. 2 Electrical connections - (not to scale)



## **ABSOLUTE MAXIMUM RATINGS - PER ARM**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>CES</sub>	Collector-emitter voltage	$V_{GE} = 0V$	1200	V
V <sub>GES</sub>	Gate-emitter voltage	-	±20	V
I <sub>c</sub>	Continuous collector current	$T_{case} = 85^{\circ}C$	800	А
I <sub>C(PK)</sub>	Peak collector current	1ms, T <sub>case</sub> = 110°C	1600	А
P <sub>max</sub>	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 150^{\circ}C$	6940	W
l²t	Diode I <sup>2</sup> t value (IGBT arm)	$V_R = 0, t_p = 10 \text{ms}, T_{vj} = 125^{\circ}\text{C}$	100	kA <sup>2</sup> s
	Diode I <sup>2</sup> t value (Diode arm)		225	kA <sup>2</sup> s
V <sub>isol</sub>	Isolation voltage - per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	2500	V
$Q_{_{PD}}$	Partial discharge - per module	IEC1287. V <sub>1</sub> = 1500V, V <sub>2</sub> = 1100V, 50Hz RMS	10	PC



# THERMAL AND MECHANICAL RATINGS

Internal insulation material: AIN
Baseplate material: AISiC
Creepage distance: 20mm
Clearance: 10mm
CTI (Critical Tracking Index): 175

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
R <sub>th(j-c)</sub>	Thermal resistance - transistor (per arm)	Continuous dissipation -	-	-	18	°C/kW
		junction to case				
R <sub>th(j-c)</sub>	Thermal resistance - diode (IGBT arm)	Continuous dissipation -	-	-	40	°C/kW
	Thermal resistance - diode (Diode arm)	junction to case	-	-	27	°C/kW
R <sub>th(c-h)</sub>	Thermal resistance - case to heatsink	Mounting torque 5Nm	-	-	8	°C/kW
	(per module)	(with mounting grease)				
T <sub>j</sub>	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	125	°C
T <sub>stg</sub>	Storage temperature range	-	-40	-	125	°C
-	Screw torque	Mounting - M6	-	-	5	Nm
		Electrical connections - M4	-	-	2	Nm
		Electrical connections - M8	-	-	10	Nm



## **ELECTRICAL CHARACTERISTICS**

 $T_{case} = 25$ °C unless stated otherwise.

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Units
I <sub>CES</sub>	Collector cut-off current	$V_{GE} = 0V, V_{CE} = V_{CES}$		-	-	1	mA
		$V_{GE} = 0V$ , $V_{CE} = V_{CES}$ , $T_{case} = 125$	°C	-	-	25	mA
I <sub>GES</sub>	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$		-	-	4	μΑ
$V_{\text{GE(TH)}}$	Gate threshold voltage	$I_{\rm C} = 40 {\rm mA}, V_{\rm GE} = V_{\rm CE}$		4.5	5.5	6.5	V
V <sub>CE(sat)</sub> †	Collector-emitter saturation voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> = 800A		-	2.2	2.6	V
		$V_{GE} = 15V, I_{C} = 800A, T_{case} = 12$	25°C	-	2.6	3.0	V
I <sub>F</sub>	Diode forward current	DC		-	-	800	Α
I <sub>FM</sub>	Diode maximum forward current	t <sub>p</sub> = 1ms		-	-	1600	Α
V <sub>F</sub> †	Diode forward voltage (IGBT arm)	I <sub>F</sub> = 800A		-	2.1	2.4	V
	Diode forward voltage (Diode arm)			-	1.8	2.1	V
	Diode forward voltage (IGBT arm)	I <sub>F</sub> = 800A, T <sub>case</sub> = 125°C		-	2.1	2.4	V
	Diode forward voltage (Diode arm)			-	1.7	2.0	V
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz		-	90	-	nF
L <sub>M</sub>	Module inductance - per arm	-		-	20	-	nH
R <sub>INT</sub>	Internal transistor resistance - per arm	-		-	0.27	-	mΩ
SC <sub>Data</sub>	Short circuit. I <sub>sc</sub>	$T_j = 125^{\circ}C, V_{CC} = 900V,$	I <sub>1</sub>		5500	-	Α
		$t_p \le 10\mu s$ , $V_{CE(max)} = V_{CES} - L^*$ . di/dt	I <sub>2</sub>		4500	-	Α
		IEC 60747-9					

# Note:

<sup>&</sup>lt;sup>†</sup> Measured at the power busbars and not the auxiliary terminals)

<sup>\*</sup> L is the circuit inductance +  $L_{\rm M}$ 



# **ELECTRICAL CHARACTERISTICS**

 $T_{case} = 25$ °C unless stated otherwise

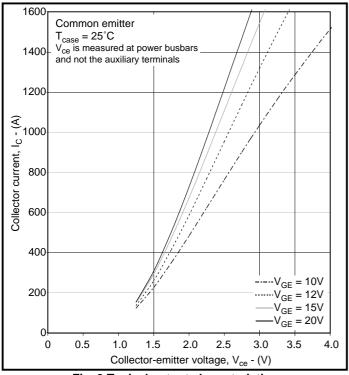
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 800A	-	1250	-	ns
t <sub>f</sub>	Fall time	V <sub>GE</sub> = ±15V	-	170	-	ns
E <sub>OFF</sub>	Turn-off energy loss	V <sub>CE</sub> = 600V	-	130	-	mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = R_{G(OFF)} = 2.7\Omega$	-	250	-	ns
t,	Rise time	L ~ 100nH	-	250	-	ns
E <sub>on</sub>	Turn-on energy loss		-	80	-	mJ
$Q_g$	Gate charge		-	9	-	μС
Q <sub>rr</sub>	Diode reverse recovery charge	$I_F = 800A, V_R = 600V,$	-	80	-	μС
I <sub>rr</sub>	Diode reverse current	dl <sub>F</sub> /dt = 4200A/μs	-	380	-	А
E <sub>REC</sub>	Diode reverse recovery energy		-	30	-	mJ

# T<sub>case</sub> = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>c</sub> = 800A	-	1500	-	ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$	-	200	-	ns
E <sub>OFF</sub>	Turn-off energy loss	V <sub>CE</sub> = 600V	-	160	-	mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = R_{G(OFF)} = 2.7\Omega$	-	400	-	ns
t <sub>r</sub>	Rise time	L ~ 100nH	-	220	-	ns
E <sub>on</sub>	Turn-on energy loss		-	120	-	mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 800A, V <sub>R</sub> = 600V,	-	160	-	μС
I <sub>rr</sub>	Diode reverse current	dI <sub>F</sub> /dt = 4000A/μs	-	450	-	Α
E <sub>REC</sub>	Diode reverse recovery energy		-	60	-	mJ



### **TYPICAL CHARACTERISTICS**



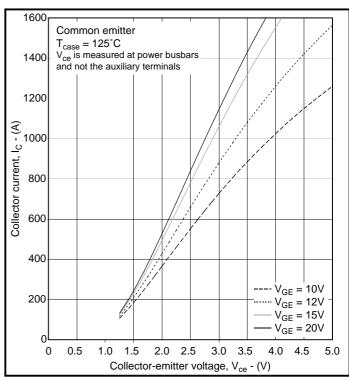


Fig. 3 Typical output characteristics



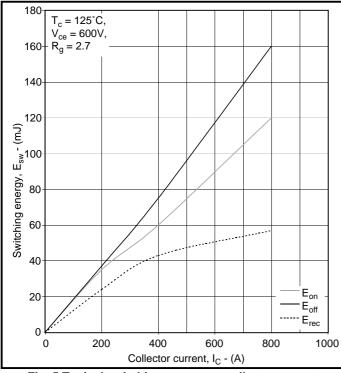


Fig. 5 Typical switching energy vs collector current

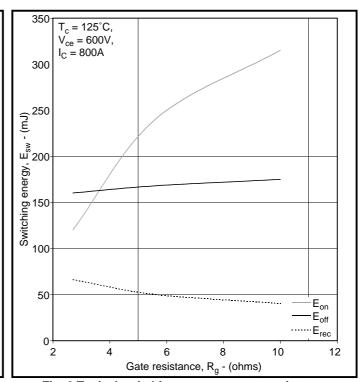
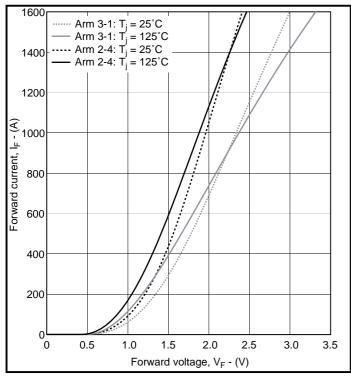


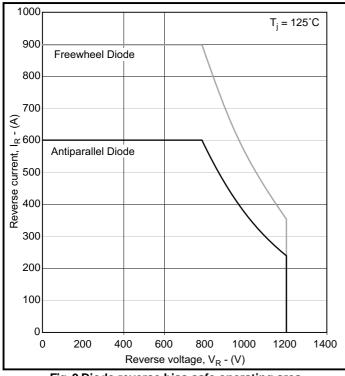
Fig. 6 Typical switching energy vs gate resistance

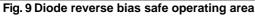




2000  $T_{case} = 125^{\circ}C$   $V_{ge} = 15V$ 1800  $R_g^{\circ}$  = 2.70hms 1600 1400 Collector current, Ic. (A) 400 200 Module I<sub>C</sub> Chip  $I_{\mathbb{C}}$ 0 400 600 800 1000 1400 1200 Collector emitter voltage, V<sub>ce</sub> - (V) Fig. 8 Reverse bias safe operating area

Fig. 7 Diode typical forward characteristics





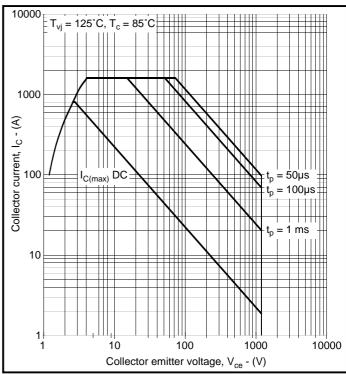
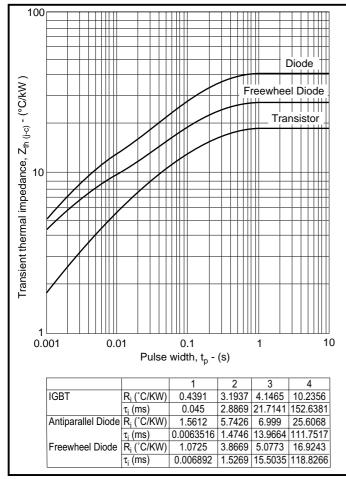


Fig. 10 Forward bias safe operating area





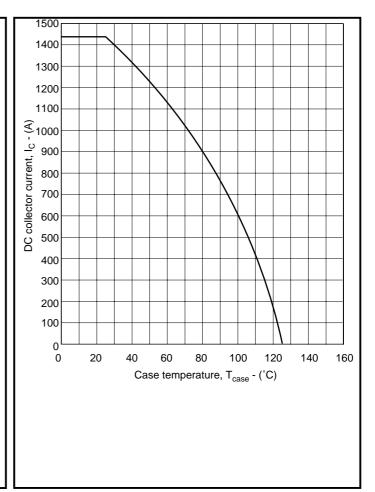


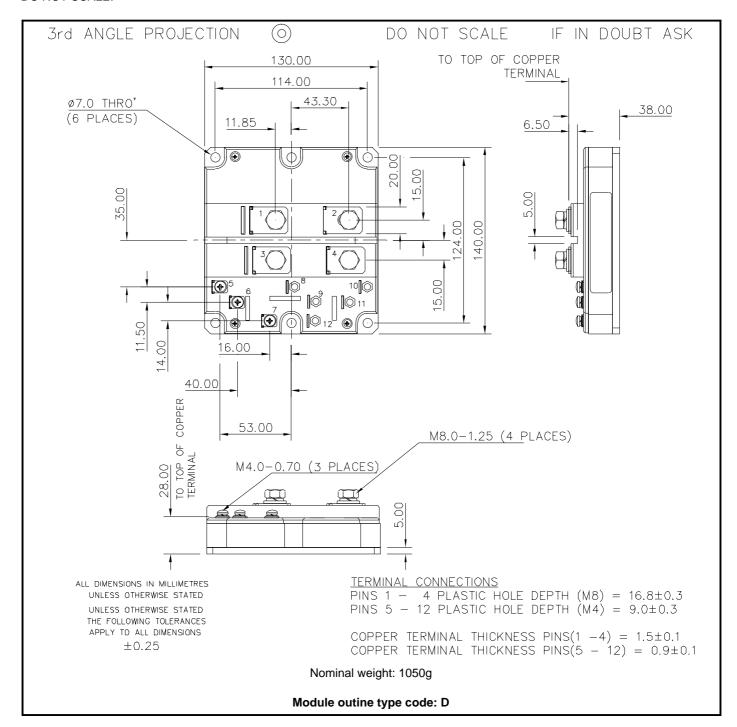
Fig. 13 Transient thermal impedance

Fig. 15 DC current rating vs case temperature



### **PACKAGE DETAILS**

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.





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The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink and clamping systems in line with advances in device voltages and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group continues to offer high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

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The Power Assembly group has its own proprietary range of extruded aluminium heatsinks. They have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or customer service office.



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